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Kind regards,

Team Nexperia

### INTEGRATED CIRCUITS

# DATA SHEET

# 74ALVCH16823

18-bit bus-interface D-type flip-flop with reset and enable (3-State)

Product specification

1998 Jul 29

IC24 Data Handbook





### 18-bit D-type flip-flop (3-State)

### 74ALVCH16823

### **FEATURES**

- Wide supply voltage range of 1.2V to 3.6V
- Complies with JEDEC standard no. 8-1A.
- CMOS low power consumption
- Direct interface with TTL levels
- Current drive ± 24 mA at 3.0 V
- Multibyte™flow-through standard pin-out architecture
- Low inductance multiple V<sub>CC</sub> and GND pins to minimize noise and ground bounce
- All data inputs have bus hold
- Output drive capability 50Ω transmission lines @ 85°C

### **DESCRIPTION**

The 74ALVCH16823 is a 18-bit edge-triggered flip-flop featuring separate D-type inputs for each flip-flop and 3-state outputs for bus oriented applications. Incorporates bushold data inputs which eliminate the need for external pull-up resistors to hold unused inputs. The74ALVCH16823 consists of two sections of nine edge-triggered flip-flops. A clock (CP) input, an output-enable ( $\overline{\text{OE}}$ ) input, a Master reset ( $\overline{\text{MR}}$ ) input and a clock-enable( $\overline{\text{CE}}$ ) input are provided for each total 9-bit section.

With the clock-enable ( $\overline{\text{CE}}$ ) input LOW, the D-type flip-flops will store the state of their individual D-inputs that meet the set-up and hold time requirements on the LOW-to-HIGH CP transition. Taking  $\overline{\text{CE}}$  HIGH disables the clock buffer, thus latching the outputs. Taking the Master reset ( $\overline{\text{MR}}$ ) input LOW causes all the Q outputs to go LOW independently of the clock.

When  $\overline{\text{OE}}$  is LOW, the contents of the flip-flops are available at the outputs. When the  $\overline{\text{OE}}$  is HIGH, the outputs go to the high impedance OFF-state. Operation of the  $\overline{\text{OE}}$  input does not affect the state of flip-flops.

Active bus hold circuitry is provided to hold unused or floating data inputs at a valid logic level.

### **QUICK REFERENCE DATA**

GND = 0V;  $T_{amb} = 25^{\circ}C$ ;  $t_r = t_f \le 2.5 \text{ ns}$ 

SYMBOL	PARAMETER	CONDITION	IS	TYPICAL	UNIT	
t <sub>PHL</sub> /t <sub>PLH</sub>	Propagation delay CP to Qn	V <sub>CC</sub> = 2.5V, CL = 30pF V <sub>CC</sub> = 3.3V, CL = 50pF	2.1 2.1	ns		
F <sub>max</sub>	Maximum clock frequency	V <sub>CC</sub> = 2.5V, CL = 30pF V <sub>CC</sub> = 3.3V, CL = 50pF	300 350	MHz		
C <sub>I</sub>	Input capacitance					
C	Power dissipation capacitance per latch	$V_1 = GND$ to $V_{CC}^1$	Outputs enabled	16	pF	
C <sub>PD</sub>	rower dissipation capacitance per laten	AL = GIAD IO ACC.	Outputs disabled	10	þΓ	

### NOTES:

 $P_D = C_{PD} \times V_{CC}^2 \times f_i + \Sigma (C_L \times V_{CC}^2 \times f_o)$  where:

 $f_i$  = input frequency in MHz;  $C_L$  = output load capacity in pF;

 $f_0$  = output frequency in MHz;  $V_{CC}$  = supply voltage in V;

 $\Sigma (C_L \times V_{CC}^2 \times f_0) = \text{sum of outputs.}$ 

### **ORDERING INFORMATION**

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	DWG NUMBER
56-Pin Plastic SSOP Type II	-40°C to +85°C	74ALVCH16823 DL	ACH16823 DL	SOT371-1
56-Pin Plastic TSSOP Type II	-40°C to +85°C	74ALVCH16823 DGG	ACH16823 DGG	SOT364-1

<sup>1.</sup>  $C_{PD}$  is used to determine the dynamic power dissipation ( $P_D$  in  $\mu W$ ):

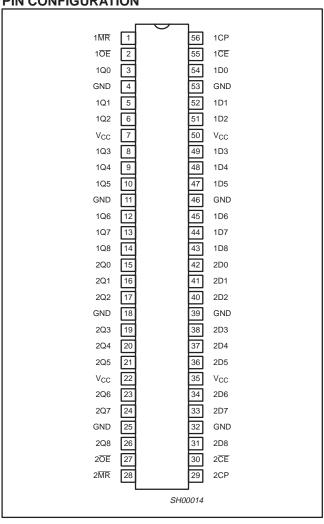
# 18-bit D-type flip-flop (3-State)

### 74ALVCH16823

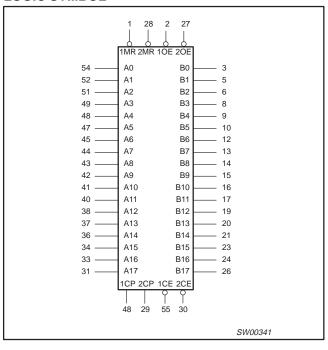
### **PIN DESCRIPTION**

PIN NUMBER	SYMBOL	FUNCTION
2, 27	1 <del>0</del> E, 2 <del>0</del> E	Output enable input (active-Low)
54, 52, 51, 49, 48, 47, 45, 44, 43 42, 41, 40, 38, 37, 36, 34, 33, 31	1D0-1D8 2D0-2D8	Data inputs
3, 5, 6, 8, 9, 10, 12, 13, 14 15, 16, 17, 19, 20, 21, 23, 24, 26	1Q0-1Q8 2Q0-2Q8	Data outputs
56, 29	1CP, 2CP	Clock pulse input (active rising edge)
55, 30	1CE, 2CE	Clock enable input (active-Low)
1, 28	1MR, 2MR	Master reset input (active-Low)
4, 11, 18, 25, 32, 39, 46, 53	GND	Ground (0V)
7, 22, 35, 50	V <sub>CC</sub>	Positive supply voltage

### **PIN CONFIGURATION**



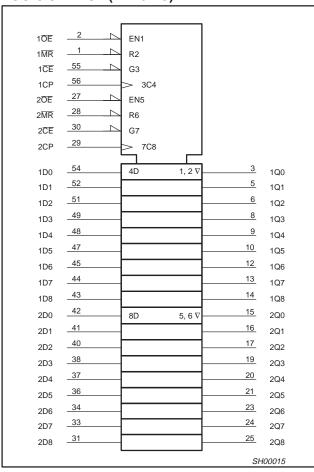
### **LOGIC SYMBOL**



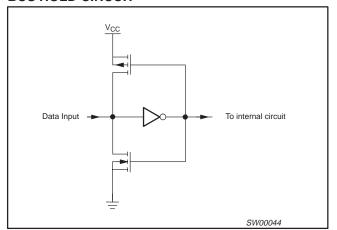
## 18-bit D-type flip-flop (3-State)

### 74ALVCH16823

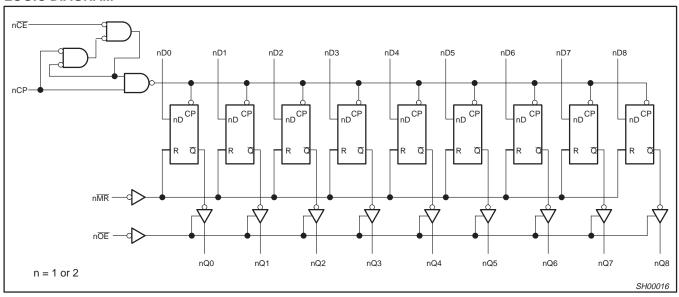
### LOGIC SYMBOL (IEEE/IEC)



### **BUS HOLD CIRCUIT**



### **LOGIC DIAGRAM**



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## 18-bit D-type flip-flop (3-State)

### 74ALVCH16823

### **FUNCTION TABLE**

		INPUTS			OUTPUT	OPERATING MODES			
nŌĒ	nMR	nCE	nCP	nDx	nQx	J. EKATING MODES			
L	L	Х	Х	Х	L	Clear			
L	Н	L	1	h	Н	Load and read data			
L	Н	L	1	I	L	Load and read data			
L	Н	L	L	Х	$Q_0$	Hold			
L	Н	Н	Х	Х	$Q_0$	Hold			
Н	Х	Х	Х	Х	Z	Disable outputs			

H = HIGH voltage level

h = HIGH voltage level one set-up time prior to the Low-to-High clock transition

L = LOW voltage level

= LOW voltage level one set-up time prior to the Low-to-High clock transition

X = Don't care

Z = HIGH impedance "off" state

↑ = LOW to High clock transition

### RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	CONDITIONS	LIM	IITS	UNIT	
STWIBOL	PARAMETER	CONDITIONS	MIN	MAX	UNIT	
V	DC supply voltage 2.5V range (for max. speed performance @ 30 pF output load)		2.3	2.7	.,	
V <sub>CC</sub>	DC supply voltage 3.3V range (for max. speed performance @ 50 pF output load)		3.0	3.6	V	
V <sub>CC</sub>	DC supply voltage (for low-voltage applications)		1.2	3.6	V	
V	DC Input voltage range	for data input pins	0	V <sub>CC</sub>	V	
V <sub>I</sub>	DC input voltage range	for control pins	0	5.5	V	
V <sub>O</sub>	DC output voltage range		0	V <sub>CC</sub>	V	
T <sub>amb</sub>	Operating free-air temperature range		-40	+85	°C	
t <sub>r</sub> , t <sub>f</sub>	Input rise and fall times	$V_{CC} = 2.3 \text{ to } 3.0 \text{V}$ $V_{CC} = 3.0 \text{ to } 3.6 \text{V}$	0 0	20 10	ns/V	

### **ABSOLUTE MAXIMUM RATINGS**

In accordance with the Absolute Maximum Rating System (IEC 134). Voltages are referenced to GND (ground = 0V).

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT	
V <sub>CC</sub>	DC supply voltage		-0.5 to +4.6	V	
I <sub>IK</sub>	DC input diode current	V <sub>1</sub> < 0	-50	mA	
\/	DC input voltage	For control pins <sup>1</sup>	-0.5 to +5.5	V	
VI	DC input voltage	For data inputs <sup>1</sup>	-0.5 to V <sub>CC</sub> +0.5	\ \ \	
I <sub>OK</sub>	DC output diode current	$V_O > V_{CC}$ or $V_O < 0$	±50	mA	
V <sub>O</sub>	DC output voltage	Note 1	-0.5 to V <sub>CC</sub> +0.5	V	
I <sub>O</sub>	DC output source or sink current	$V_{O} = 0$ to $V_{CC}$	±50	mA	
I <sub>GND</sub> , I <sub>CC</sub>	DC V <sub>CC</sub> or GND current		±100	mA	
T <sub>stg</sub>	Storage temperature range		-65 to +150	°C	
P <sub>TOT</sub>	Power dissipation per package –plastic medium-shrink (SSOP) –plastic thin-medium-shrink (TSSOP)	For temperature range: -40 to +125 °C above +55°C derate linearly with 11.3 mW/K above +55°C derate linearly with 8 mW/K	850 600	mW	

### NOTE:

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<sup>1.</sup> The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

# 18-bit D-type flip-flop (3-State)

## 74ALVCH16823

### DC ELECTRICAL CHARACTERISTICS

Over recommended operating conditions. Voltage are referenced to GND (ground = 0 V).

			<u> </u>	LIMITS		<b></b>
SYMBOL	PARAMETER	TEST CONDITIONS		= -40°C to +		רואט
			MIN	TYP <sup>1</sup>	MAX	_
		V <sub>CC</sub> = 1.2V	V <sub>CC</sub>			1
$V_{IH}$	HIGH level Input voltage	V <sub>CC</sub> = 1.8V	0.7*V <sub>CC</sub>	0.9		<b> </b>
- 111	The state of the particular of	$V_{CC} = 2.3 \text{ to } 2.7 \text{V}$	1.7	1.2		]
		$V_{CC} = 2.7 \text{ to } 3.6 \text{V}$	2.0	1.5		
		$V_{CC} = 1.2V$		-	GND	1
$V_{IL}$	LOW level Input voltage	V <sub>CC</sub> = 1.8V		0.9	0.2*V <sub>CC</sub>	J <sub>v</sub>
- 12		$V_{CC} = 2.3 \text{ to } 2.7 \text{V}$		1.2	0.7	]
		$V_{CC} = 2.7 \text{ to } 3.6 \text{V}$		1.5	0.8	
		$V_{CC} = 1.8 \text{ to } 3.6 \text{V}; V_I = V_{IH} \text{ or } V_{IL}; I_O = -100 \mu\text{A}$	$V_{CC}-0.2$	V <sub>CC</sub>	_	
		$V_{CC} = 1.8V$ ; $V_I = V_{IH}$ or $V_{IL}$ ; $I_O = -6$ mA	V <sub>CC</sub> -0.4	V <sub>CC</sub> -0.10	_	
		$V_{CC} = 2.3V$ ; $V_I = V_{IH}$ or $V_{IL}$ ; $I_O = -6$ mA	V <sub>CC</sub> -0.3	V <sub>CC</sub> -0.08	_	]
$V_{OH}$	HIGH level output voltage	$V_{CC} = 2.3V$ ; $V_I = V_{IH}$ or $V_{IL}$ ; $I_O = -12mA$	V <sub>CC</sub> -0.5	V <sub>CC</sub> -0.17	_	V
		$V_{CC} = 2.3V$ ; $V_I = V_{IH}$ or $V_{IL}$ ; $I_O = -18$ mA	V <sub>CC</sub> -0.6	V <sub>CC</sub> -0.26	_	1
		$V_{CC} = 2.7V$ ; $V_I = V_{IH}$ or $V_{IL}$ ; $I_O = -12mA$	V <sub>CC</sub> -0.5	V <sub>CC</sub> -0.14	-	1
		$V_{CC} = 3.0V$ ; $V_I = V_{IH}$ or $V_{IL}$ ; $I_O = -24$ mA	V <sub>CC</sub> -1.0	V <sub>CC</sub> -0.28	-	1
		$V_{CC} = 1.8 \text{ to } 3.6 \text{V}; \ V_I = V_{IH} \text{ or } V_{IL}; I_O = 100 \mu\text{A}$		GND	0.20	
		$V_{CC} = 1.8V$ ; $V_I = V_{IH}$ or $V_{IL}$ ; $I_O = 6mA$		0.09	0.30	1
		$V_{CC} = 2.3V$ ; $V_I = V_{IH}$ or $V_{IL}$ ; $I_O = 6mA$		0.07	0.20	1
$V_{OL}$	LOW level output voltage	$V_{CC} = 2.3V; V_I = V_{IH} \text{ or } V_{IL}; I_O = 12\text{mA}$		0.15	0.40	
		$V_{CC} = 2.3V; V_I = V_{IH} \text{ or } V_{IL}; I_O = 18\text{mA}$		0.23	0.60	1
		$V_{CC} = 2.7V; V_I = V_{IH} \text{ or } V_{IL}; I_O = 12\text{mA}$		0.14	0.40	1
		$V_{CC} = 3.0V; V_I = V_{IH} \text{ or } V_{IL}; I_O = 24\text{mA}$		0.27	0.55	1
	Input leakage current per control pin	V <sub>CC</sub> = 1.8 to 3.6V; V <sub>I</sub> = 5.5V or GND		0.1	5	1
l <sub>1</sub>	Input leakage current per data pin	$V_{CC} = 1.8 \text{ to } 3.6V;$ $V_{I} = V_{CC} \text{ or GND}$		0.1	5	μΑ
1 /	Input current for common I/O	$V_{CC}$ = 1.8 to 2.7V; $V_I = V_{CC}$ or GND		0.1	10	
I <sub>IHZ</sub> /I <sub>ILZ</sub>	pins	$V_{CC} = 3.6V;$ $V_I = V_{CC}$ or GND		0.1	15	μΑ
l	3-State output OFF-state	$V_{CC}$ = 1.8 to 2.7V; $V_I$ = $V_{IH}$ or $V_{IL}$ ; $V_O$ = $V_{CC}$ or GND		0.1	5	μА
l <sub>OZ</sub>	current	$V_{CC}$ = 2.7 to 3.6V; $V_I$ = $V_{IH}$ or $V_{IL}$ ; $V_O$ = $V_{CC}$ or GND		0.1	10	] μλ
$\Delta I_{CC}$	Additional quiescent supply current given per data I/O pin	$V_{CC} = 2.7V \text{ to } 3.6V; V_I = V_{CC} - 0.6V; I_O = 0$		150	750	μА
I <sub>BHL</sub>	Bus hold LOW sustaining current	$V_{CC} = 2.3V; V_1 = 0.7V^2$ $V_{CC} = 3.0V; V_1 = 0.8V^2$	45 75	- 150		μА
	Bus hold HIGH sustaining	$V_{CC} = 2.3V; V_1 = 1.7V^2$	-45	<del>                                     </del>	<del>                                     </del>	$\vdash$
I <sub>BHH</sub>	current	$V_{CC} = 3.0V; V_1 = 2.0V^2$	-75	<b>–175</b>		μΑ
		$V_{CC} = 2.7V^2$	300	.,,	<del>                                     </del>	+
I <sub>BHLO</sub>	Bus hold LOW overdrive current	$V_{CC} = 3.6V^2$	450	<del>                                     </del>	<del>                                     </del>	μΑ
	Due held IIIOH sweether	$V_{CC} = 3.0V$ $V_{CC} = 2.7V^2$	<del>-300</del>		-	$\vdash$
Івнно	Bus hold HIGH overdrive current	$V_{CC} = 3.6V^2$	-300 -450	<del>                                     </del>		μΑ

All typical values are at T<sub>amb</sub> = 25°C.
 Valid for data inputs of bus hold parts.

## 18-bit D-type flip-flop (3-State)

74ALVCH16823

### AC CHARACTERISTICS FOR $V_{CC}$ = 2.3V TO 2.7V RANGE AND $V_{CC}$ < 2.3V

 $GND = 0V; \ t_r = t_f \leq 2.0 ns; \ C_L = 30 pF$ 

						LIM	ITS				
SYMBOL	PARAMETER	WAVEFORM	Vcc	= 2.3 to	2.7V	٧	<sub>CC</sub> = 1.8	3V	V <sub>CC</sub> = 1.2V	UNIT	
			MIN	TYP <sup>1, 2</sup>	MAX	MIN	TYP1	MAX	TYP <sup>1</sup>	1	
t <sub>PLH</sub> /t <sub>PHL</sub>	Propagation delay nCP to nQ <sub>n</sub>	1, 5	1.0	2.8	4.9	1.5	4.5	7.5	10.6	ns	
t <sub>PLH</sub> /t <sub>PHL</sub>	Propagation delay nMR to nQ <sub>n</sub>	2, 5	1.0	2.9	5.0	1.5	4.6	7.4	9.9	ns	
t <sub>PZH</sub> /t <sub>PZL</sub>	3-State output enable time $n\overline{\text{OE}}_n$ to $nQ_n$	4, 5	1.0	2.8	5.3	1.5	4.4	7.7	10.4	ns	
t <sub>PHZ</sub> /t <sub>PLZ</sub>	3-State output disable time nOE <sub>n</sub> to nQ <sub>n</sub>	4, 5	1.0	2.2	4.1	1.5	3.3	5.5	6.7	ns	
t <sub>W</sub>	nCP pulse width	1, 5	3.0	1.6		4.0	2.0			ns	
ιW	nMR pulse width, LOW	3, 5	3.0	0.4		4.0	0.8			1115	
t	Set up time nD <sub>n</sub> to nCP	3, 5	1.2	0.2		1.5	0.2			nc	
t <sub>SU</sub>	Set up time nCE to nCP	] 3, 3	1.8	-0.2		2.0	-0.2			ns	
4.	Hold time nD <sub>n</sub> to nCP	3, 5	0.8	-0.1		0.6	-0.2			no	
t <sub>h</sub>	Hold time nCE to nCP	3, 5	0.3	0.2		0.3	0.2			ns	
t <sub>rec</sub>	Recovery time nMR to nCP	2, 5	1.0	0.3		0.8	0.2			ns	
F <sub>max</sub>	Maximum clock pulse frequency	1, 5	150	300		125	250			MHz	

# AC CHARACTERISTICS FOR V<sub>CC</sub> = 3.0V TO 3.6V RANGE AND V<sub>CC</sub> = 2.7V GND = 0V; $t_r$ = $t_f$ $\leq$ 2.5ns; $C_L$ = 50pF

					LII	MITS				
SYMBOL	PARAMETER	WAVEFORM	Vc	C = 3.0 ± 0	0.3V	'	/ <sub>CC</sub> = 2.7	V	UNIT	
			MIN	TYP <sup>1, 2</sup>	MAX	MIN	TYP <sup>1</sup>	MAX	1	
t <sub>PLH</sub> /t <sub>PHL</sub>	Propagation delay nCP to nQ <sub>n</sub>	1, 5	1.0	2.5	3.7	1.0	2.7	4.3	ns	
t <sub>PLH</sub> /t <sub>PHL</sub>	Propagation delay nMR to nQ <sub>n</sub>	2, 5	1.0	2.6	4.0	1.0	3.1	4.6	ns	
t <sub>PZH</sub> /t <sub>PZL</sub>	3-State output enable time nOE <sub>n</sub> to nQ <sub>n</sub>	4, 5	1.0	2.5	4.3	1.0	3.1	5.2	ns	
t <sub>PHZ</sub> /t <sub>PLZ</sub>	3-State output disable time nOE <sub>n</sub> to nQ <sub>n</sub>	4, 5	1.0	2.8	3.9	1.0	3.1	4.3	ns	
t <sub>W</sub>	nCP pulse width HIGH or LOW	1, 5	2.5	1.4		3.0	1.6		ns	
ιγγ	nMR pulse width HIGH or LOW	3, 5	2.5	0.3		3.0	0.6		1 115	
<b>+</b>	Set up time nD <sub>n</sub> to nCP	3, 5	1.2	0.2		1.5	0.4		no	
t <sub>SU</sub>	Set up time nCE to nCP	3, 5	1.5	-0.1		1.9	-0.1		ns	
	Hold time nD <sub>n</sub> to nCP	2.5	0.8	0.0		0.6	-0.2		no	
t <sub>h</sub>	Hold time nCE to nCP	3, 5	0.5	0.1		0.4	0.1		ns	
t <sub>rec</sub>	Recovery time nMR to nCP	2, 5	1.0	0.2		0.8	0.1		ns	
F <sub>max</sub>	Maximum clock pulse frequency	1, 5	200	350		150	300		MHz	

All typical values are measured at T<sub>amb</sub> = 25°C.
 Typical value is measured at V<sub>CC</sub> = 2.5V.

<sup>1.</sup> All typical values are measured at  $T_{amb} = 25$ °C.

<sup>2.</sup> Typical value is measured at  $V_{CC} = 3.3V$ .

# 18-bit D-type flip-flop (3-State)

### 74ALVCH16823

### AC WAVEFORMS FOR $V_{CC} = 2.3V$ TO 2.7V AND V<sub>CC</sub> < 2.3V RANGE

 $V_{M} = 0.5 V_{CC}$  $V_X = V_{OL} + 0.15V$  $V_{Y} = V_{OH} - 0.15V$ 

Vol. and VoH are the typical output voltage drop that occur with the output load.

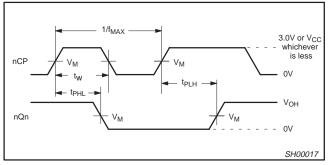
### AC WAVEFORMS FOR $V_{CC} = 3.0V$ TO 3.6V AND V<sub>CC</sub> = 2.7V RANGE

 $V_{M} = 1.5 \text{ V}$ 

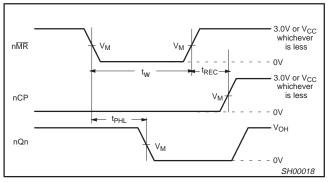
 $V_X = V_{OL} + 0.3V$   $V_Y = V_{OH} - 0.3V$ 

V<sub>OL</sub> and V<sub>OH</sub> are the typical output voltage drop that occur with the output load.

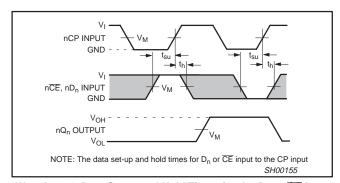
 $V_1 = 2.7V$ 



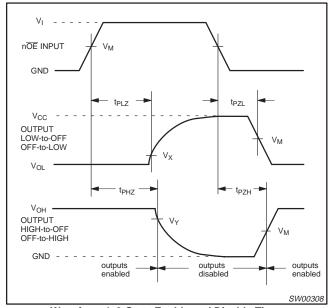
Waveform 1. Clock (nCP) to Output (nQn) Propagation Delays, Clock Pulse Width, and Maximum Clock Pulse Frequency



Waveform 2. Master Reset (MR) Pulse Width, MR to Output propagation Delay and MR to Clock Recovery Time

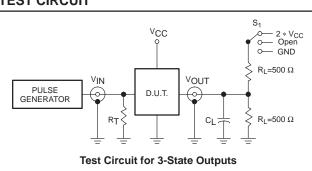


Waveform 3. Data Setup and Hold Times for the D<sub>n</sub> or CE input to the CP input



Waveform 4, 3-State Enable and Disable Times

### **TEST CIRCUIT**



### **SWITCH POSITION**

TEST	SWITCH
t <sub>PLH</sub> /t <sub>PHL</sub>	Open
t <sub>PLZ</sub> /t <sub>PZL</sub>	2 * V <sub>CC</sub>
t <sub>PHZ</sub> /t <sub>PZH</sub>	GND

V <sub>CC</sub>	V <sub>IN</sub>
< 2.7V 2.7 – 3.6V	V <sub>CC</sub> 2.7V

### **DEFINITIONS**

R<sub>L</sub> = Load resistor

 $C_L$  = Load capacitance includes jig and probe capacitance

 $R_T$  = Termination resistance should be equal to  $Z_{OUT}$ of pulse generators.

SW00047

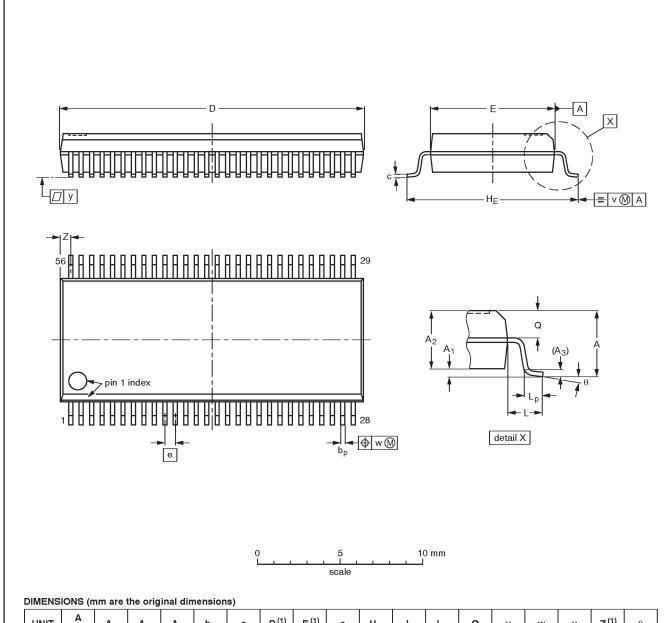
Waveform 5. Load circuitry for switching times

# 18-bit bus-interface D-type flip-flop with reset and enable (3-State)

### 74ALVCH16823

### SSOP56: plastic shrink small outline package; 56 leads; body width 7.5 mm

SOT371-1



UNIT	A max.	Α <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	bp	С	D <sup>(1)</sup>	E <sup>(1)</sup>	е	HE	L	Lp	Q	v	w	у	Z <sup>(1)</sup>	θ
mm	2.8	0.4 0.2	2.35 2.20	0.25	0.3 0.2	0.22 0.13	18.55 18.30	7.6 7.4	0.635	10.4 10.1	1.4	1.0 0.6	1.2 1.0	0.25	0.18	0.1	0.85 0.40	8° 0°

### Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	EIAJ		PROJECTION	ISSUE DATE
SOT371-1		MO-118AB				<del>93-11-02</del> 95-02-04

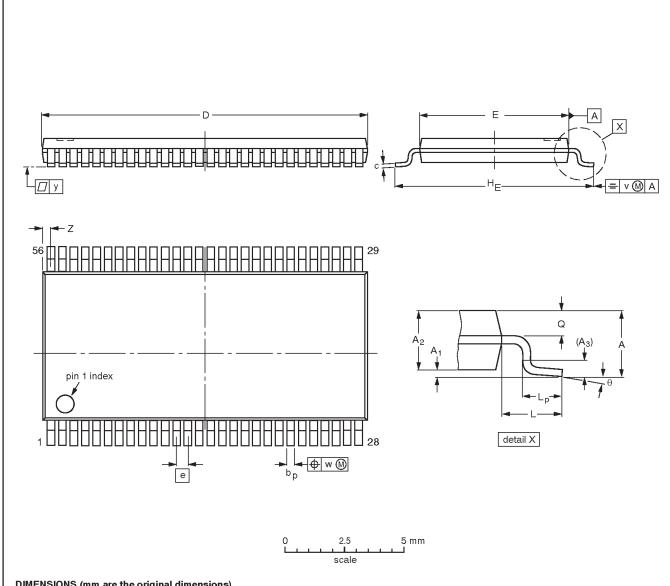
1998 Jul 29 9

# 18-bit bus-interface D-type flip-flop with reset and enable (3-State)

### 74ALVCH16823

### TSSOP56: plastic thin shrink small outline package; 56 leads; body width 6.1mm

SOT364-1



### DIMENSIONS (mm are the original dimensions).

UNIT	A max.	A <sub>1</sub>	A <sub>2</sub>	A <sub>3</sub>	bp	С	D <sup>(1)</sup>	E <sup>(2)</sup>	е	HE	L	Lp	Q	v	w	у	z	θ
mm	1.2	0.15 0.05	1.05 0.85	0.25	0.28 0.17	0.2 0.1	14.1 13.9	6.2 6.0	0.5	8.3 7.9	1.0	0.8 0.4	0.50 0.35	0.25	0.08	0.1	0.5 0.1	8° 0°

- 1. Plastic or metal protrusions of 0.15 mm maximum per side are not included.
- 2. Plastic interlead protrusions of 0.25 mm maximum per side are not included.

VERSION IEC JEDEC EIAJ PROJECTION	OUTLINE			EUROPEAN	ISSUE DATE		
93-02-	VERSION	IEC	JEDEC	EIAJ		PROJECTION	1930E DATE
501364-1   WIO-133EE   95-02-	SOT364-1	, in	MO-153EE				<del>-93-02-03</del> 95-02-10

18-bit bus-interface D-type flip-flop with reset and enable (3-State)

74ALVCH16823

**NOTES** 

# 18-bit bus-interface D-type flip-flop with reset and enable (3-State)

74ALVCH16823

### Data sheet status

Data sheet status	Product status	Definition [1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
Preliminary specification	Qualification	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make chages at any time without notice in order to improve design and supply the best possible product.
Product specification	Production	This data sheet contains final specifications. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.

<sup>[1]</sup> Please consult the most recently issued datasheet before initiating or completing a design.

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